# LSI/CSI LS7061/7063



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## **32 BIT/DUAL 16 BIT BINARY UP COUNTER** January 2003 WITH BYTE MULTIPLEXED THREE-STATE OUTPUTS

## FEATURES:

- DC to 15MHz Count Frequency
- Byte Multiplexer
- DC to 1MHz Scan Frequency
- +4.75V to +5.25V Operation (VDD VSS)
- Latch Provided for External High Speed Counter Byte, Effectively Extending Count Frequency to 3.84GHz
- Three-State Data Outputs, Bus and TTL Compatible
- Inputs TTL and CMOS Compatible
- Unique Cascade Feature Allows Multiplexing of Successive Bytes of Data in Sequence in Multiple Counter Systems
- LS7061, LS7063 (DIP); LS7061-S, LS7063-S (SOIC) - See Figures 1 & 2

## **DESCRIPTION:**

The LS7061/LS7063 is a MOS, 32 bit/dual 16 bit up counter. The IC includes 40 latches, multiplexer, eight three-state binary data output drivers and output cascading logic.

## **DESCRIPTION OF OPERATION:**

#### 32 (16) BIT BINARY UP COUNTER - LS7061 (LS7063)

The 32 (16) bit static ripple through counter increments on the negative edge of the input count pulse. Maximum ripple time is 4µs (2µs) - transition count of 32 (16) ones to 32 (16) zeros. Guaranteed count frequency is DC to 15MHz. See Figure 8A (8B) for Block Diagram.

## COUNT - LS7061, COUNT A - LS7063

Input count pulses to the 32 (first 16) bit counter may be applied through this input. This input is the most significant bit of the external data byte.

## COUNT B - LS7063

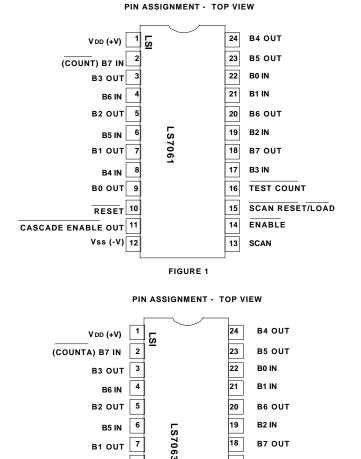
Count pulses may be applied to the last 16 bits of the binary counter through this input. The counter advances on the negative transition of these pulses.

#### RESET

All 32 counter bits are reset to zero when RESET is brought low for a minimum of 1µs. RESET must be high for a minimum of 300ns before next valid count can be recorded. COUNT B must be held low when RESET is brought low to ensure proper reset of Counter B for LS7063.

## TEST COUNT - LS7061

Count pulses may be applied to the last 16 bits of the binary counter through this input, as long as Bit 16 of the counter is a low. The counter advances on the negative transition of these pulses. This input is intended to be used for test purposes.



#### LATCHES - LS7061 (LS7063)

B1 OUT

B0 OUT

RESET

Vss (-V) 12

CASCADE ENABLE OUT

B4 IN

8

9

10

11

40 bits of latch are provided, eight for storage of the contents of a high speed external prescaling counter and the remaining 32 for the contents of the counter data. All latches are loaded when the LOAD input is brought low for a minimum of 1µs and kept low until a minimum of 4µs (2µs) has elapsed from previous negative edge of count pulse (ripple time). Storage of valid data occurs when LOAD is brought high for a minimum of 250ns before next negative edge of count pulse or RESET.

FIGURE 2

17

16

15

14

13

B3 IN

COUNT B

ENABLE

SCAN

SCAN RESET/LOA

#### SCAN COUNTER AND DECODER

The scan counter is reset to the least significant byte position (State 1) when SCAN RESET input is brought low for a minimum of 1µs. The scan counter is enabled for counting as long as the ENABLE input is held low. The counter advances to the next significant byte position on each negative transition of the SCAN pulse. When the scan counter advances to State 6 it disables the Output Drivers and stops in that state until SCAN RESET is again brought low.

#### SCAN

When the scan counter is enabled, each negative transition of this input advances the scan counter to its next state. When SCAN is low the Data Outputs are disabled. When SCAN is brought high the Data Outputs are enabled and present the latched counter data corresponding to the present state of the scan counter. Therefore, in microprocessor applications, the Data Output Bus may be utilized for other activities while new data is propagating to the outputs. This positive SCAN pulse can be viewed as a "Place the next byte on my bus" instruction from the microprocessor. Minimum positive and negative pulse widths of 500ns for the SCAN signal are required for scan counter operation.

#### SCAN RESET/LOAD

When this input is brought low for a minimum of  $1\mu$ s, the scan counter is reset to State 1, the least significant byte position, and the latches are simultaneously loaded with new count information.

#### ENABLE

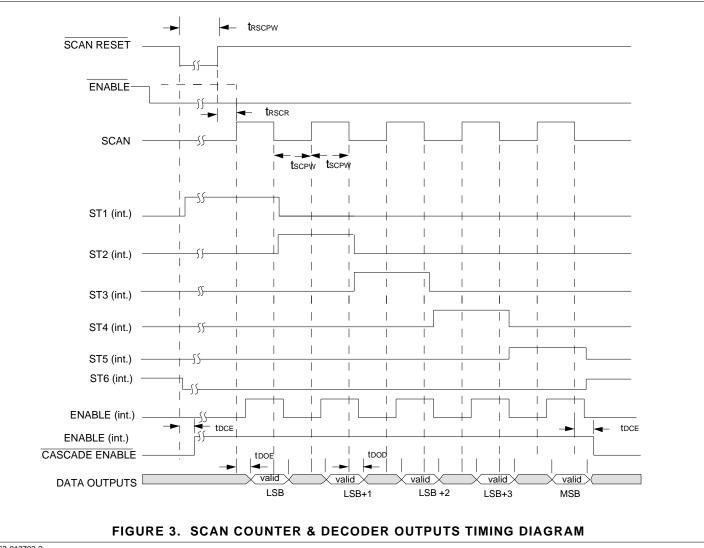
When this input is high, the scan counter and the Data Outputs are disabled. When ENABLE is low, the scan counter and Data Outputs are enabled for normal operation. Transition of this input should only be made while the SCAN input is in a low state in order to prevent false clocking of the scan counter.

#### CASCADE ENABLE

This output is normally high. It transitions low and stays low when the scan counter advances to <u>State 6</u>. In a multiple counter system this output is connected to the <u>ENABLE</u> input of the next counter in the cascade string. The SCAN input and <u>SCAN RESET/LOAD</u> input are carried to all the counters in the "Cascade". Counter 1 then presents its bytes of data to the Output Bus on each positive transition of the SCAN pulse as previously discussed. When State 6 of Counter 1 is achieved, Counter 2 presents its data to the Output Bus. This sequence continues until all counters in the cascade have been addressed. See Figure 5 for an illustration of a 3 device cascade design. This output is TTL and CMOS compatible.

#### THREE-STATE DATA OUTPUT DRIVERS

The eight Data Output Drivers are disabled when either ENABLE input is high, the scan counter is in State 6, or the SCAN input is low. The Output Drivers are TTL and Bus compatible.



ABSOLUTE MAXIMUM RATINGS:							
PARAMETER	SYMBOL	VALUE	UNIT				
StorageTemperature	Tstg	-55 to +150	°C				
Operating Temperature	ТА	0 to +70	°C				
Voltage (any pin to Vss)	Vin	+10 to -0.3	V				

## DC ELECTRICAL CHARACTERISTICS:

(VDD = +5V  $\pm$  5%, Vss = 0V, TA = 0°C to + 70°C unless otherwise noted.)

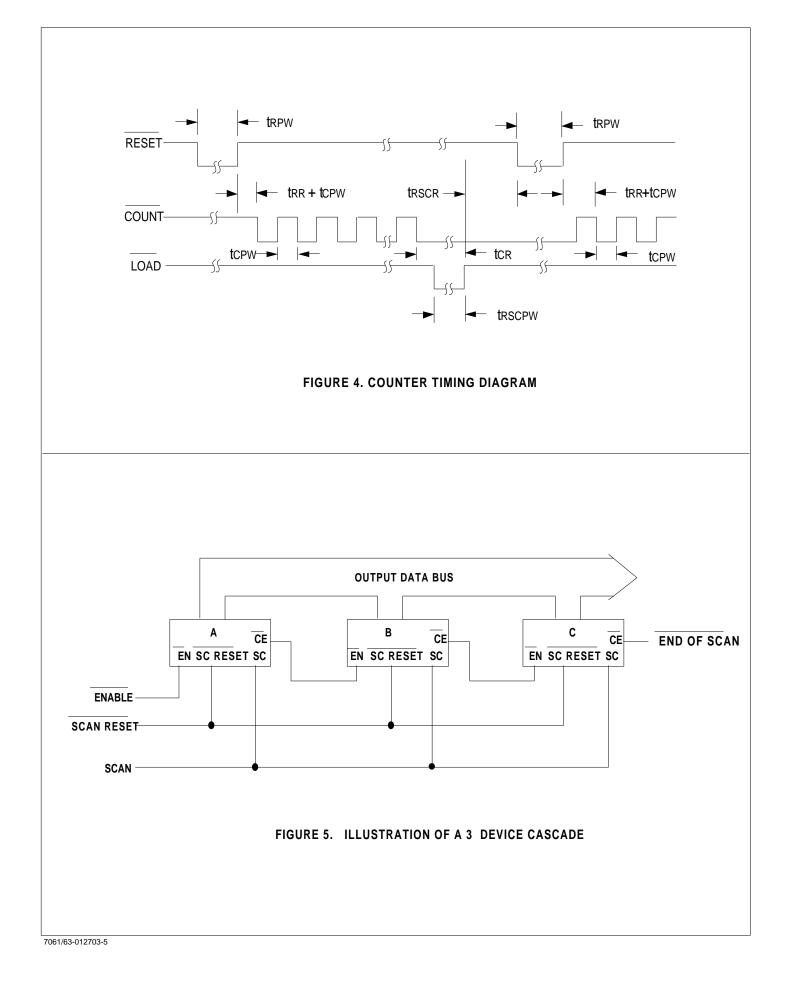
PARAMETER Power Supply Current	SYMBOL Idd	Min -	<b>MAX</b> 15	UNIT mA	<b>CONDITIONS</b> At Maximum Operating Frequency VDD = Max, Outputs No Load
Input High Voltage	Vін	+3.5	Vdd	V	-
Input Low Voltage	VIL	0	+0.6	V	-
Output High Voltage					
CASCADE ENABLE	Vон	Vdd - 0.2 +2.4	-	V V	IO = 0, $VDD = Min$
		+2.4	-	V	$IO = -100\mu A$ , VDD = Min
B0 - B7		+2.4	-	V	IO = -260µA, VDD = Min
20 2.		+2.0	-	v	$IO = -750\mu A$ , $VDD = Min$
				-	
Output Low Voltage					
CASCADE ENABLE	Vol	-	+0.2	V	IO = 0, VDD = Min
			+0.4	V	IO = 1.6 mA, $VDD = Min$
B0 - B7			+0.4	V	IO = 1.6mA, VDD = Min
Output Source Current	Isource	3.0	-	mA	Vo = +1.2V, Vdd = Min
B0 - B7 Outputs	1300100	4.8		mA	VO = +0.8V, VDD = Min
Do Di Outputs		7.3	-	mA	VO = +0.6V, VDD = Min
Output Sink Current	Isink	5.7		mA	VO = +1.2V, $VDD = Min$
B0 - B7 Outputs	ISHIK	4.0	-	mA	VO = +0.8V, VDD = Min
Bo Broupaio		2.2	-	mA	VO = +0.4V, VDD = Min
Output Leakage Current	IOL	-	1	μA	VO = +0.4V to $+2.4V$ , VDD = Min
B0 - B7 (Off State)	.01		·	P., .	
Input Capacitance	CIN	-	6	pF	TA = 25°C, f = 1MHz
Output Capacitance	COUT	-	12	pF	TA = 25°C, f = 1MHz
Input Leakage Current	ILI	-	1	, Au	VDD = Max
ENABLE, RESET, SCAN				·	
			0.5		
*SCAN RESET/LOAD	Ін	-	-2.5	μA	VDD = Max, VIH = +3.5
	I	-	-5	μA	VDD = Max, VIL = 0
**B0 - B7, COUNT B, TEST COUNT	Ін	-	5	μA	VDD = Max, VIH = +3.5
	lı∟	-	1	μA	VDD = Max, VIL = 0

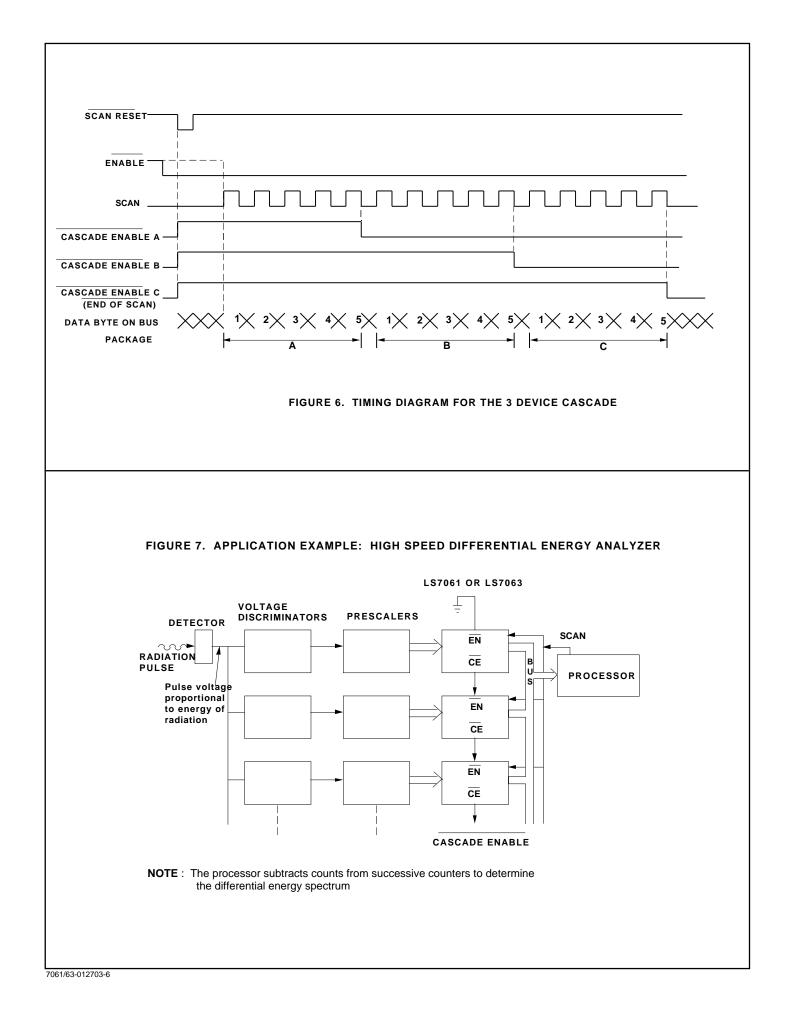
\*Input has internal pull-up resistor to VDD

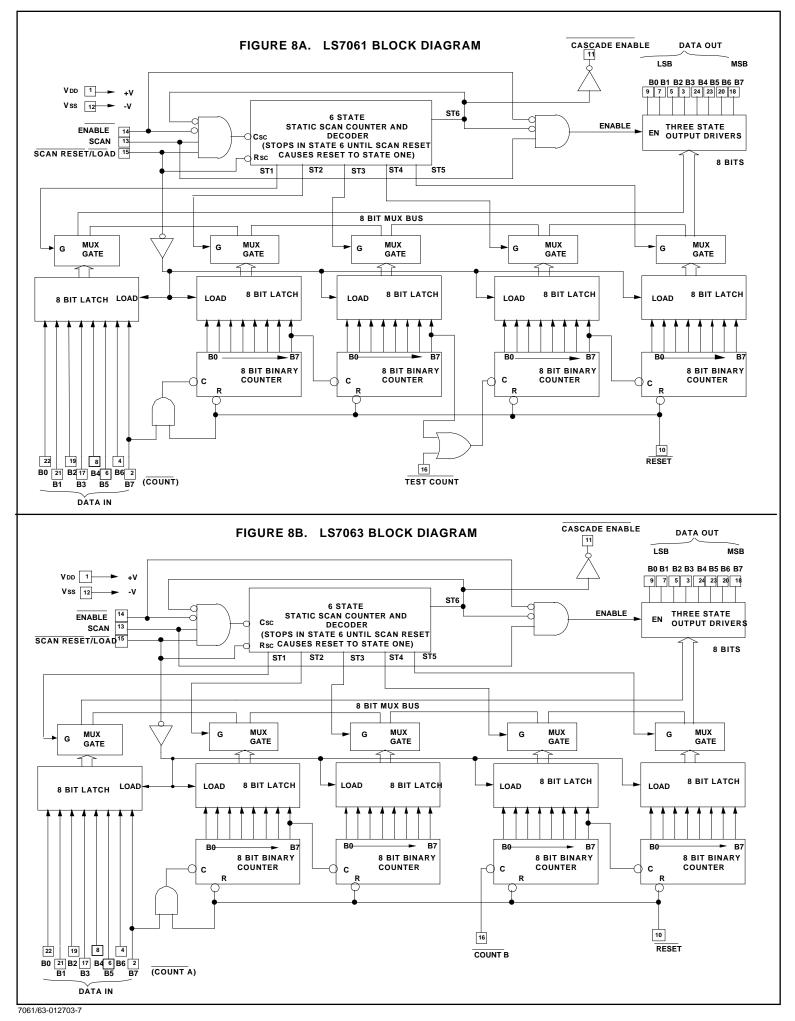
\*\* Inputs have internal pull-down resistor to Vss

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<b>DYNAMIC ELECTRICAL CHARACTERISTICS:</b> (Refer to Figure 3, Timing Diagram) $(VDD = +5V \pm 5\%, Vss = 0V, TA = 0^{\circ}C to +70^{\circ}C unless otherwise noted.)$							
PARAMETER Count Frequency (All Count inputs)	SYMBOL fc	MIN DC	<b>MAX</b> 15	<b>UNIT</b> MHz	CONDITIONS -		
(All Count Inputs) (All Count Inputs)	<b>t</b> CPW	30	-	ns	Measured at 50% point, Max tr, tr = 10ns		
Count Rise & Fall time (Pins 2, 16)	tr, tf	-	30	μs			
Count Ripple Time (Pin 2 - LS7061)	tCR	-	4	μs	Transition from 32 ones to 32 zeros from negative edge of count pulse		
Count Ripple Time (Pin 13 - LS7061) (Pins 2, 13 - LS7063)	tCR	-	2	μs	Transition of 16 bits from all ones to all zeros from negative edge of count pulse		
RESET Pulse Width (All Counter Stages Fully Reset)	trpw	500	-	ns	Measured at 50% point, Max tr, tr = 200ns		
RESET Removal Time (Reset Removed From All Counter Stages)	trr	-	250	ns	Measured from RESET signal at V⊮		
SCAN Frequency	fsc	-	1	MHz	-		
SCAN Pulse Wildth	tscpw	500	-	ns	Measured at 50% point, Max tr, tf = 100ns		
SCAN RESET/LOAD Pulse Width (All latches loaded and Scan Counter Reset to Least Significant Byte)	<b>t</b> RSCPW	1	-	μs	Measured at 50% point, Max tr, tf = 200ns		
SCAN RESET/LOAD Removal Time (Reset Removed from Scan Counter; Load Command Removed From Latches)	<b>t</b> RSCR	-	250	ns	Measured from SCAN RESET/ LOAD at Viн		
Output Disable Delay Time (B0 - B7)	tdod	-	200	ns	Transition to Output High Impedance State Me <u>asured_</u> From Scan at Vı∟ or ENABLE at Vıн		
Output ENABLE Delay Time (B0 - B7)	tdoe	-	200	ns	Transition to Valid On State Measured from Scan at VIH and ENABLE at VIL; Delay to Valid Data Levels for CoL = 10pF and one TTL Load or Valid Data Currents for High Capacitance Loads		
Output Delay Time CASCADE ENABLE	tdce.	-	300	ns	Negative Transition from Scan at VIL and ST5 of Scan <u>Counter or Positive</u> Transition From SCAN RESET/LOAD at VIL to Valid Data Levels for CoL = 10pF and one TTL Load		







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